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آترین الکترونیک

تخصص، تنوع و کیفیت

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تهران پاساژ امجد طبقه 1 واحد 16



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General Description

This IGBT is produced using advanced MagnaChip's Field Stop Trench IGBT Technology, which provides low $V_{CE(SAT)}$, high switching performance and excellent quality.

This device is for PFC, UPS & PV inverter and Welder Applications.

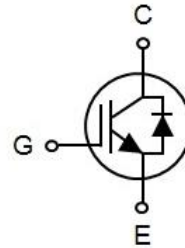
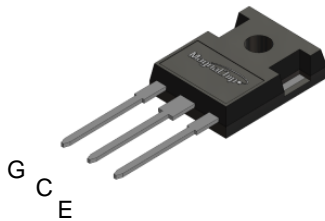
Applications

- PFC
- UPS
- Welder
- PV Inverter

Features

- High Speed Switching & Low $V_{CE(sat)}$ Loss
- $V_{CE(sat)} = 2.0V @ I_C = 25A$
- High Input Impedance
- $t_{rr} = 100ns$ (typ.) @ $di_F/dt = 500A/\mu s$
- Maximum junction temperature $175^\circ C$
- Pb-free ; RoHS compliant
- Ultra Soft, fast recovery anti-parallel diode
- Ultra Narrowed VF distribution control
- Positive Temperature coefficient for easy paralleling

TO-247



Maximum Rating

Parameter	Symbol	Rating	Unit
Collector-emitter voltage	V_{CE}	1200	V
DC collector current, limited by T_{vjmax}	I_C	$T_C=25^\circ C$	50
		$T_C=100^\circ C$	25
Pulsed collector current, t_p limited by T_{vjmax}	I_{Cpuls}	100	A
Turn off safe operating area $V_{CE} \leq 1200V, T_{vj} \leq 175^\circ C$	-	100	A
Diode forward current limited by T_{vjmax}	I_F	$T_C=25^\circ C$	25
		$T_C=100^\circ C$	12.5
Diode pulsed current, t_p limited by T_{vjmax}	I_{Fpuls}	100	A
Gate-emitter voltage	V_{GE}	± 20	V
Power dissipation	P_D	$T_C=25^\circ C$	348
		$T_C=100^\circ C$	174
Short circuit withstand time $V_{CC} \leq 600V, V_{GE} = 15V, T_{vj} = 175^\circ C$ Allowed number of short circuits < 1000 Time between short circuits $\geq 1.0s$	tsc	10	μs
Operating Junction temperature range	T_{vj}	-40~175	$^\circ C$
Storage temperature range	T_{stg}	-55~150	$^\circ C$
Soldering temperature Wave soldering 1.6 mm (0.063 in.) from case for 10s		260	$^\circ C$
Mounting torque, M3 screw Maximum of mounting processes: 3	M	0.6	Nm

Thermal Characteristic

Parameter	Symbol	Rating	Unit
Thermal resistance junction-to-ambient	$R_{\theta JA}$	40	$^\circ C/W$
Thermal resistance junction-to-case for IGBT	$R_{\theta JC}$	0.43	
Thermal resistance junction-to-case for Diode	$R_{\theta JC}$	1.55	

Ordering Information

Part Number	Marking	Temp. Range	Package	Packing	RoHS Status
MBQ25T120FESC	25T120FESC	-55~175°C	TO-247	Tube	Halogen Free

Electrical Characteristic (T_{vj} = 25°C unless otherwise specified)

Parameter	Symbol	Conditions	Min	Typ	Max	Unit	
Static Characteristic							
Collector-emitter breakdown voltage	BV _{CES}	I _C = 500μA, V _{GE} = 0V	1200	-	-	V	
Collector-emitter saturation voltage	V _{CE(sat)}	I _C = 25A, V _{GE} = 15V, T _{vj} = 25°C		2.0	2.4	V	
		I _C = 25A, V _{GE} = 15V, T _{vj} = 150°C		2.4			
		I _C = 25A, V _{GE} = 15V, T _{vj} = 175°C		2.5			
Diode forward voltage	V _F	V _{GE} = 0V, I _F = 12.5A	T _{vj} = 25°C		2.1	2.6	V
			T _{vj} = 175°C		1.9		
Diode forward voltage	V _F	V _{GE} = 0V, I _F = 25A	T _{vj} = 25°C		2.5	3.0	V
			T _{vj} = 150°C		2.55		
			T _{vj} = 175°C		2.45		
Gate-emitter threshold voltage	V _{GE(th)}	V _{CE} = V _{GE} , I _C = 0.85mA	5.0	6.0	7.0	V	
Zero gate voltage collector current	I _{CES}	V _{CE} = 1200V, V _{GE} = 0V	T _{vj} = 25°C	-	-	250	μA
			T _{vj} = 175°C	-	-	2500	
Gate-emitter leakage current	I _{GES}	V _{GE} = 20V, V _{CE} = 0V	-	-	±250	nA	
Transconductance	g _{fs}	V _{CE} = 20V, I _C = 25A,		16		S	

Dynamic Characteristic

Total gate charge	Q _g	V _{CE} = 960V, I _C = 25A, V _{GE} = 15V	-	204		nC
Gate-emitter charge	Q _{ge}		-	34		
Gate-collector charge	Q _{gc}		-	94		
Input capacitance	C _{ies}	V _{CE} = 25V, V _{GE} = 0V, f = 1MHz	-	3942	-	pF
Reverse transfer capacitance	C _{res}		-	72	-	
Output capacitance	C _{oes}		-	142	-	
Internal emitter inductance measured 5mm (0.197 in.) from case	L _E		-	13.0	-	nH
Short circuit collector current Max. 1000 short circuits Time between short circuits: ≥ 1.0s	I _{C(SC)}	V _{GE} = 15V, V _{CC} = 600V, t _{SC} ≤ 10μs, T _{vj} = 175°C	-	121	-	A

Switching Characteristic

Turn-on delay time	t _{d(on)}	V _{GE} = 15V, V _{CC} = 600V, I _C = 25A, R _G = 23Ω, Inductive Load, T _{vj} = 25°C	-	73	-	ns	
Rise time	t _r		-	41	-		
Turn-off delay time	t _{d(off)}		-	269	-		
Fall time	t _f			-	39	-	mJ
Turn-on switching energy	E _{on}			-	1.44	-	
Turn-off switching energy	E _{off}			-	0.55	-	
Total switching energy	E _{ts}			-	1.99	-	
Reverse recovery time	t _{rr}	I _F = 25A, di _F /dt = 500A/μs, V _R = 600V, T _{vj} = 25°C	-	100	-	ns	
Reverse recovery current	I _{rr}		-	17	-	A	
Reverse recovery charge	Q _{rr}		-	0.85	-	μC	
Rate of fall of reverse recovery current during t _b	di _{rr} /dt		-	-376	-	A/μs	

Switching Characteristic

Turn-on delay time	$t_{d(on)}$	$V_{GE} = 15V, V_{CC} = 600V,$ $I_C = 25A, R_G = 23\Omega,$ Inductive Load, $T_{vj} = 175^\circ C$	-	65	-	ns
Rise time	t_r		-	45	-	
Turn-off delay time	$t_{d(off)}$		-	292	-	
Fall time	t_f		-	75	-	
Turn-on switching energy	E_{on}		-	2.43	-	mJ
Turn-off switching energy	E_{off}	-	1.09	-		
Total switching energy	E_{ts}	-	3.52	-		
Reverse recovery time	t_{rr}	$I_F = 25A, di_F/dt = 500A/\mu s,$ $V_R = 600V, T_{vj} = 175^\circ C$	-	150	-	ns
Reverse recovery current	I_{rr}		-	25	-	A
Reverse recovery charge	Q_{rr}		-	1.85	-	nC
Rate of fall of reverse recovery current during t_b	di_{rr}/dt		-	-374	-	A/ μs

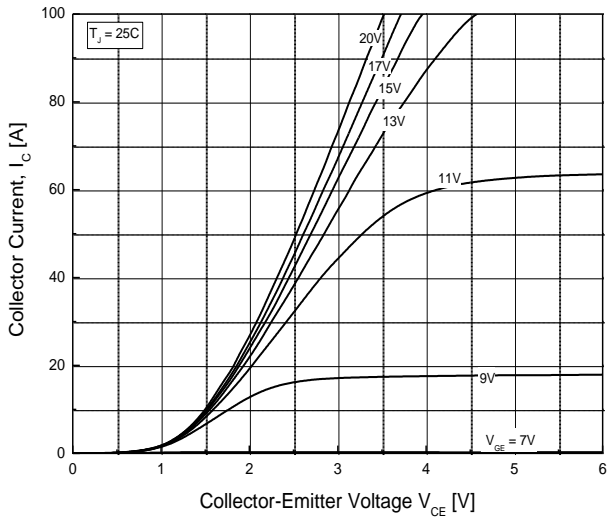


Fig.1 Typical Output Characteristic($T_J=25^\circ\text{C}$)

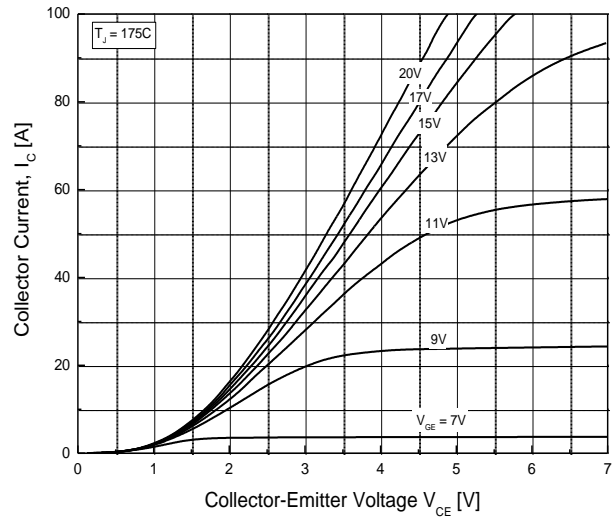


Fig.2 Typical Output Characteristic($T_J=175^\circ\text{C}$)

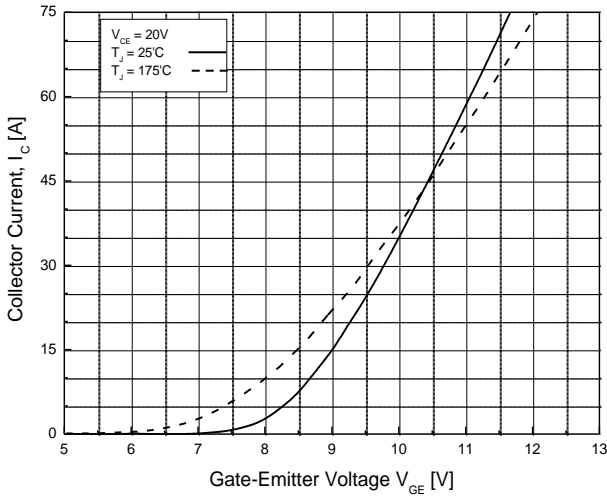


Fig.3 Typical Transfer Characteristic

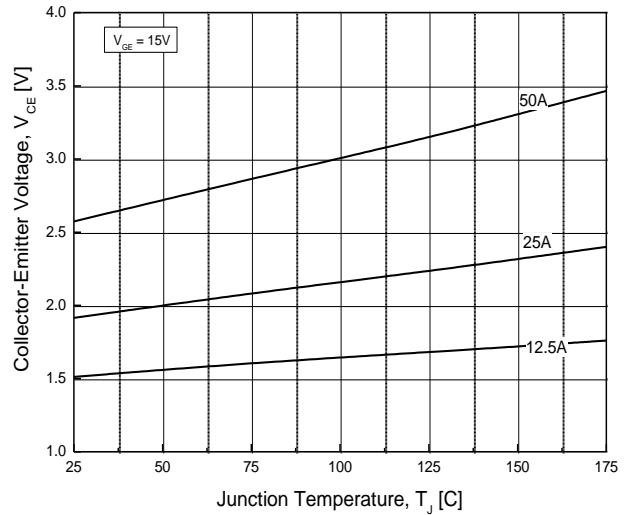


Fig.4 Typical Collector-Emitter Saturation Voltage -Junction Temperature

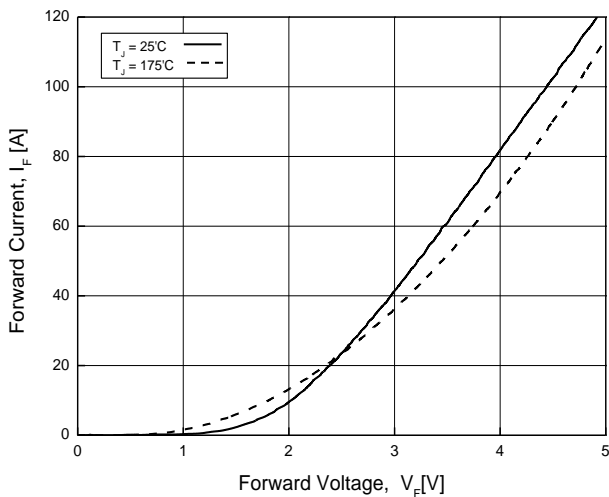


Fig.5 Diode Forward Characteristic

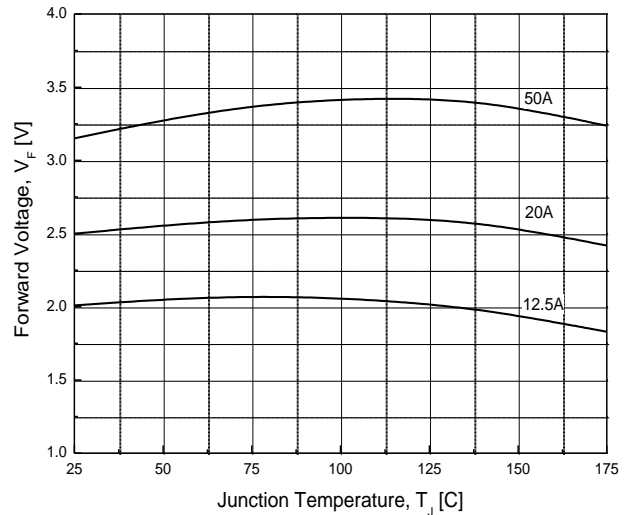


Fig.6 Diode Forward-Junction Temperature

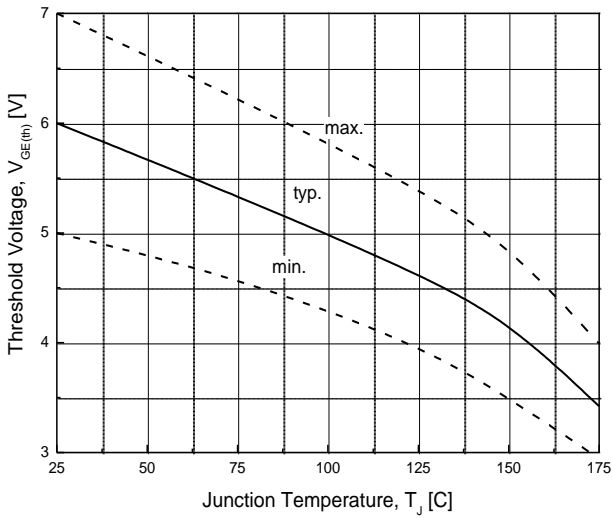


Fig.7 Threshold Voltage-Junction Temperature

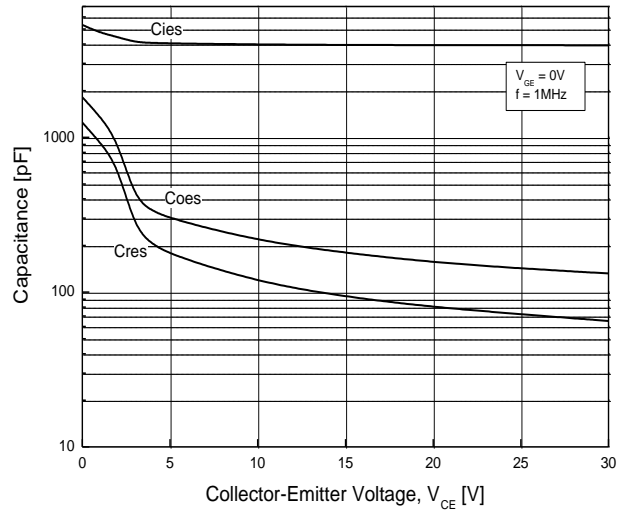


Fig.8 Typical Capacitance

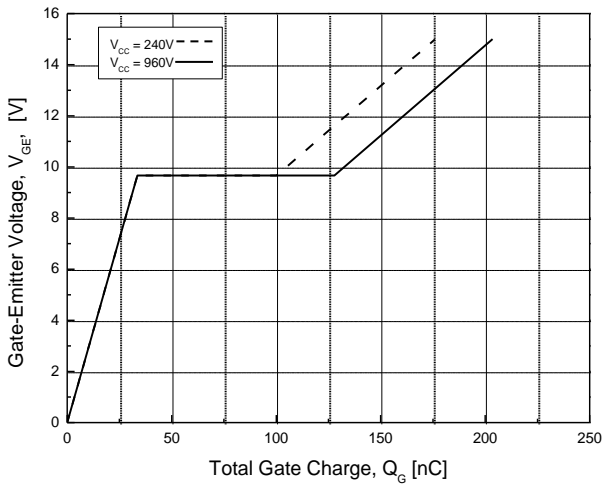


Fig.9 Typical Gate Charge

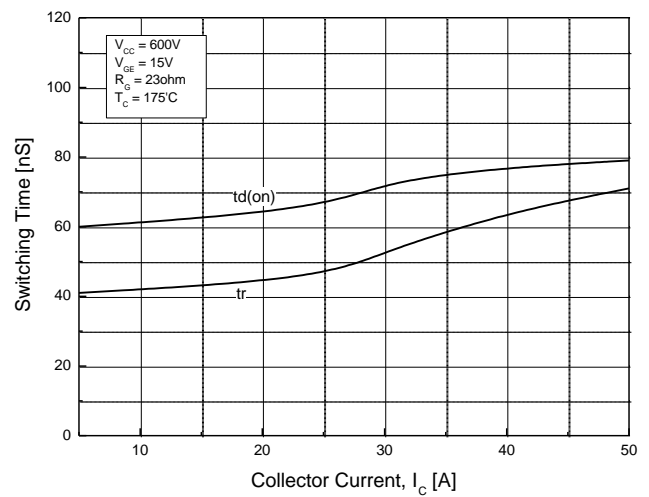


Fig.10 Typical Turn on-Collector Current

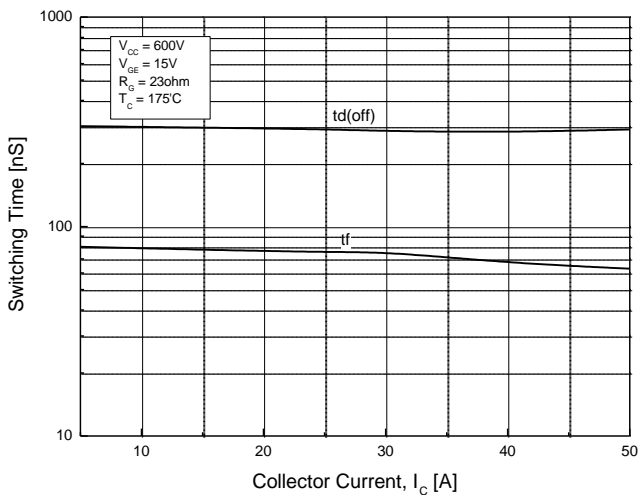


Fig.11 Typical Turn off-Collector Current

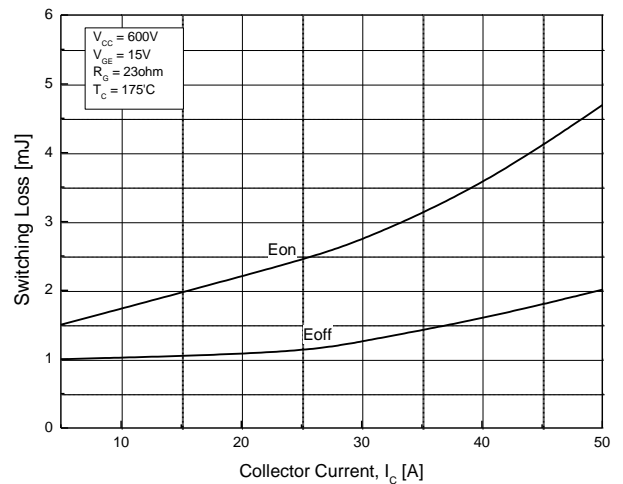


Fig.12 Switching Loss-Collector Current

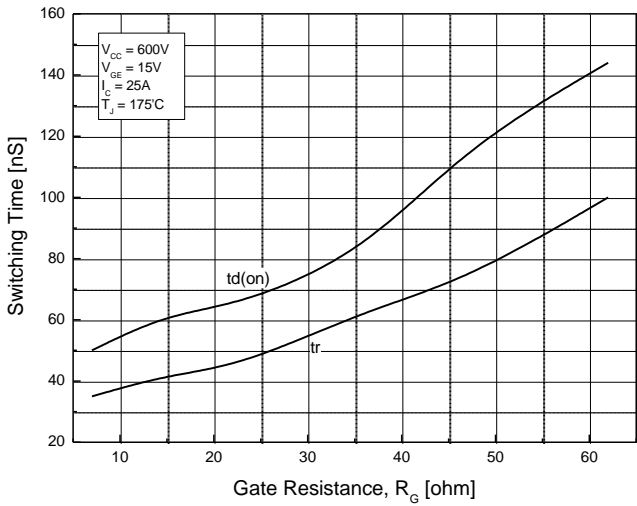


Fig.13 Turn on Characteristic-Gate Resistance

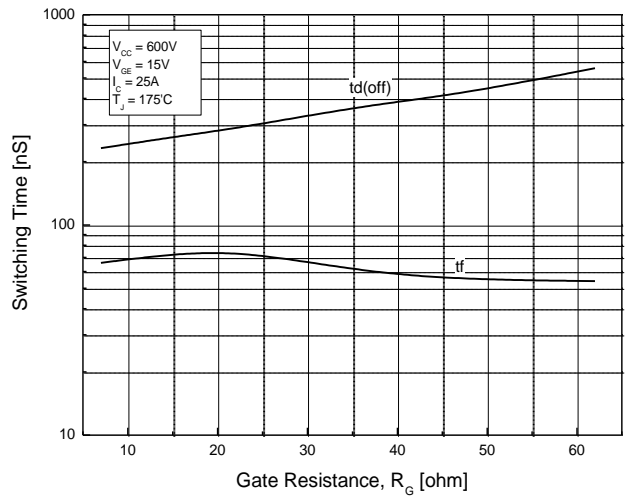


Fig.14 Turn off Characteristic-Gate Resistance

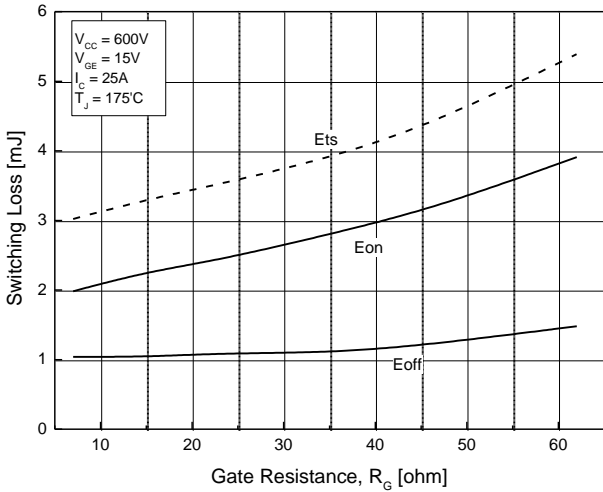


Fig.15 Switching Loss-Gate Resistance

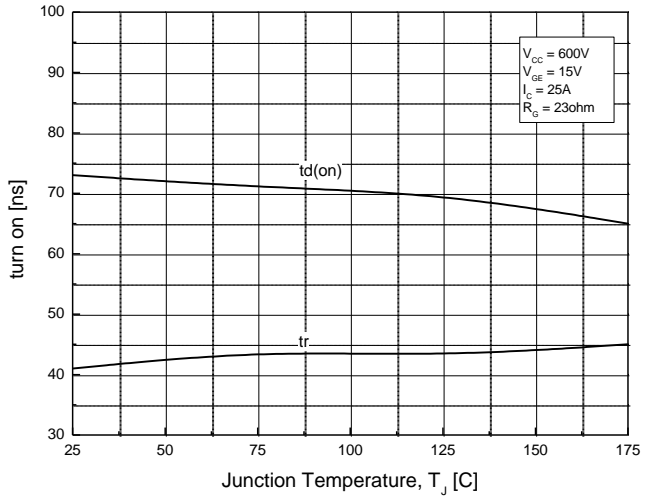


Fig.16 Turn on Characteristic-Junction Temperature

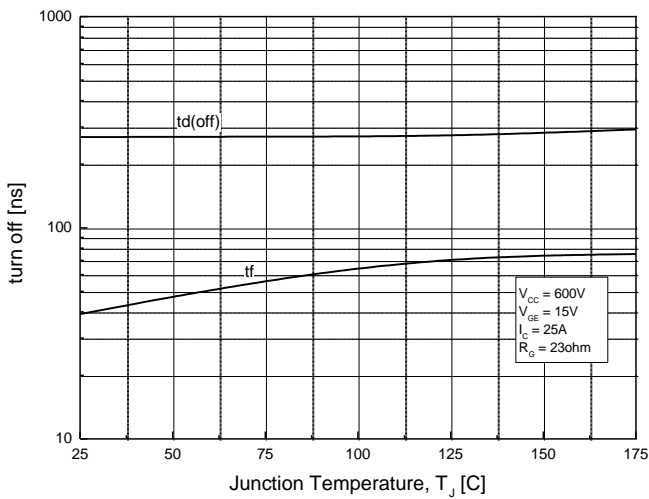


Fig.17 Turn off Characteristic-Junction Temperature

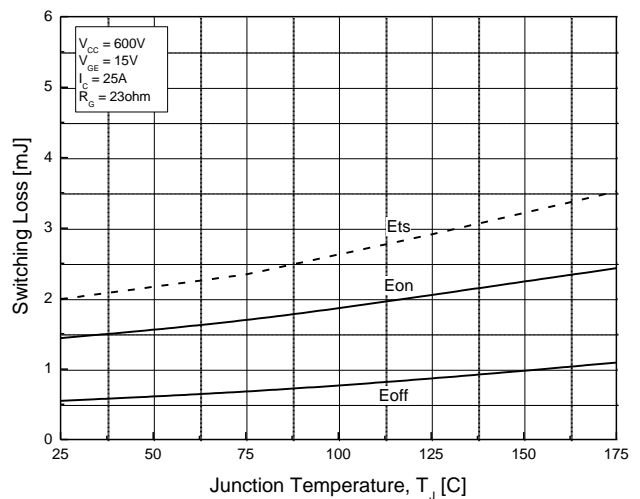


Fig.18 Switching Loss-Junction Temperature

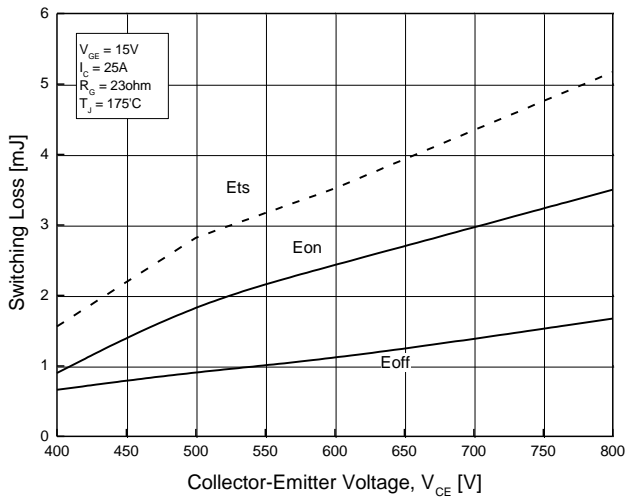


Fig.19 Switching Loss-Collector Emitter Voltage

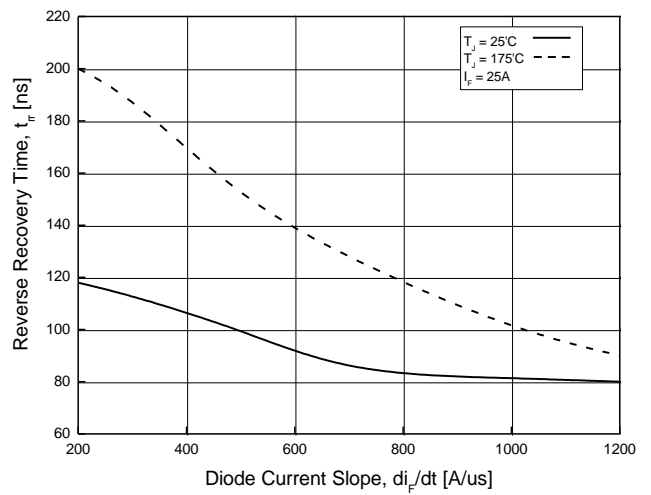


Fig.20 Reverse Recovery Time -Diode current slope

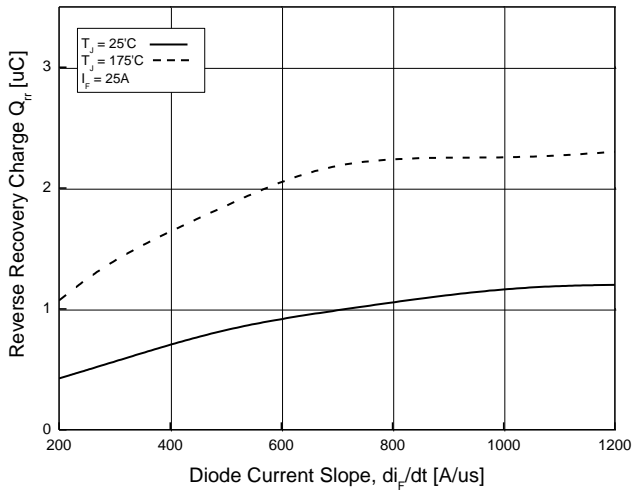


Fig.21 Reverse Recovery Charge -Diode Current Slope

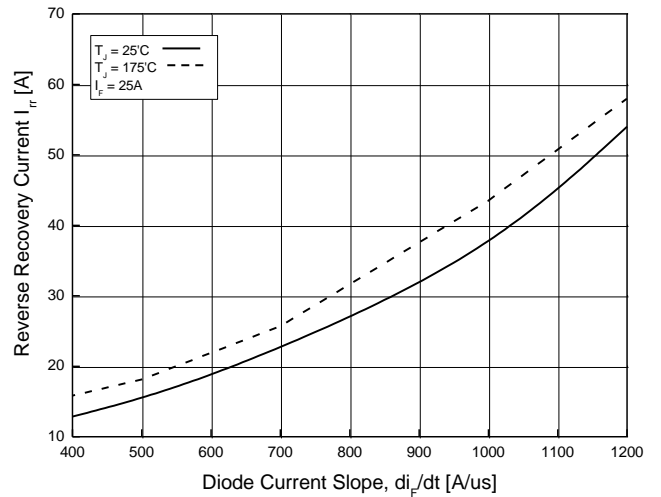


Fig.22 Reverse Recovery Current -Diode current slope

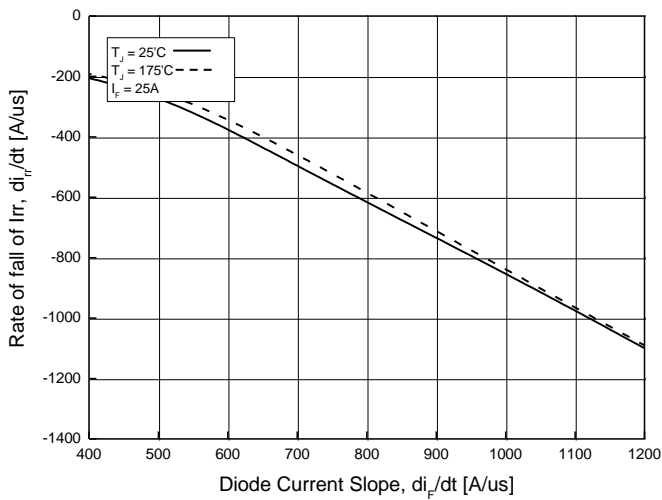


Fig.23 Rate of fall of reverse recovery current -Diode Current Slope

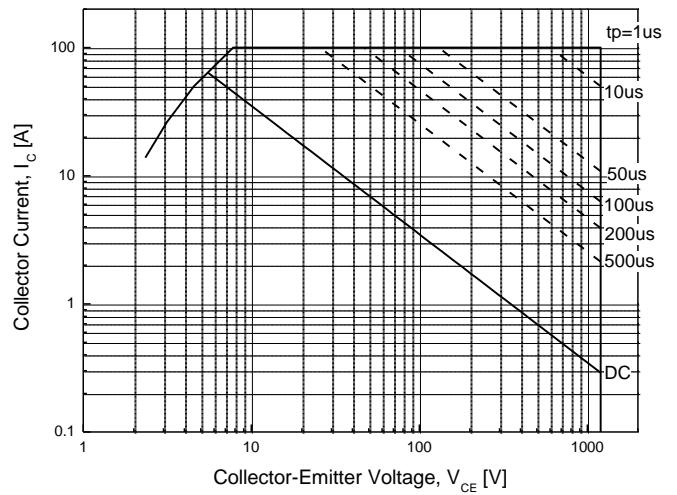


Fig.24 Forward Bias Safe Operating Area

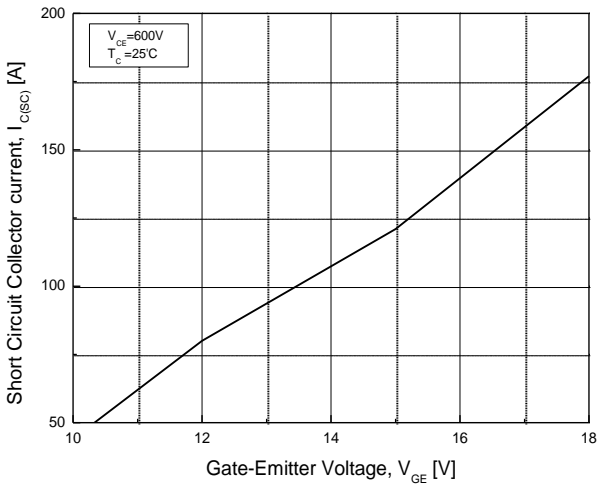


Fig.25 Typical Short Circuit Collector Current

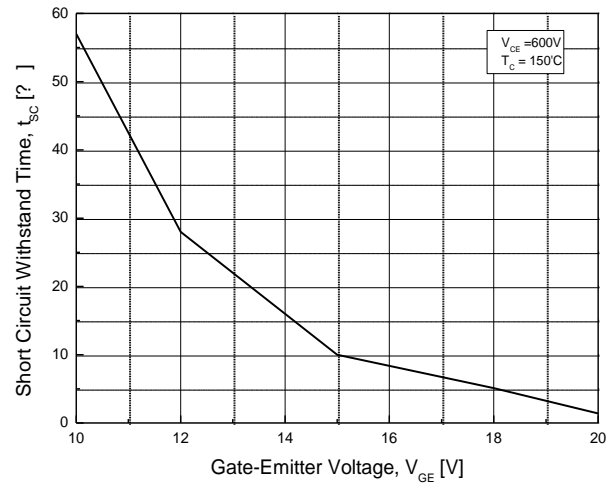


Fig.26 Typical Short Circuit Withstand Time

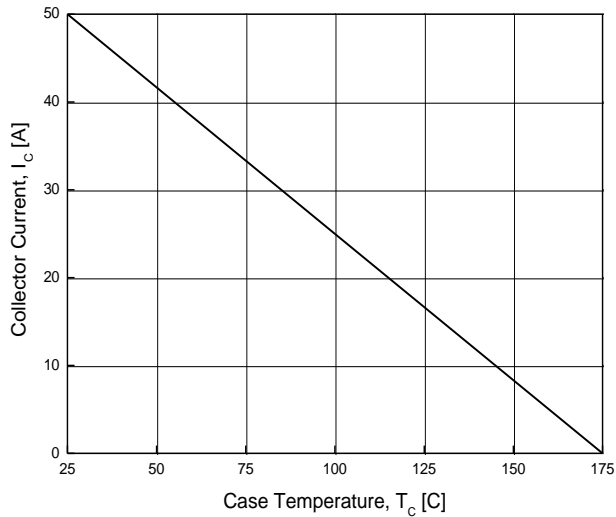


Fig.27 Case Temperature-Collector Current

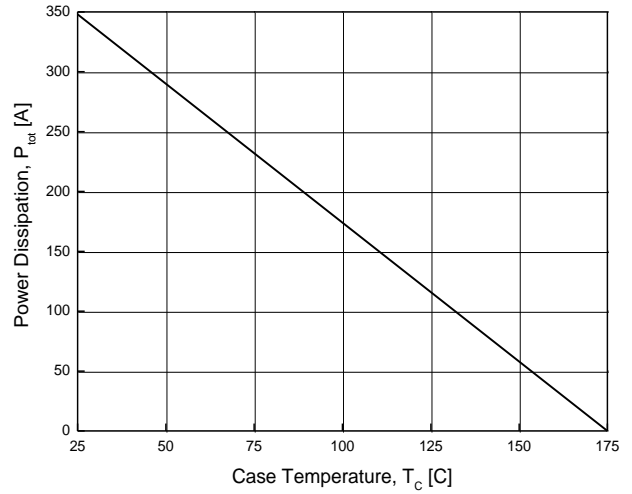


Fig.28 Power Dissipation-Case Temperature

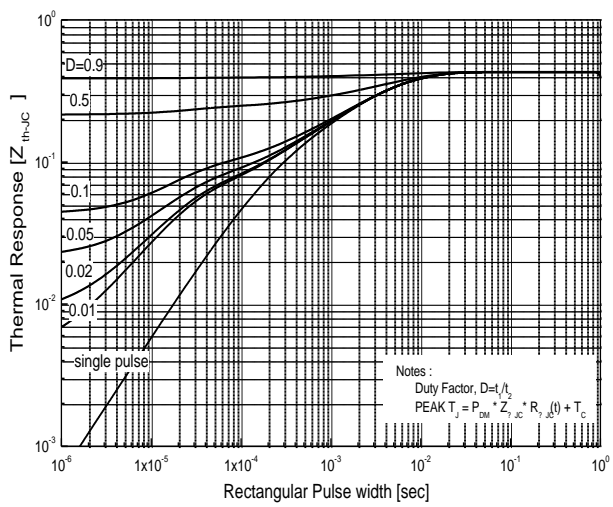


Fig.29 IGBT Transient Thermal Impedance

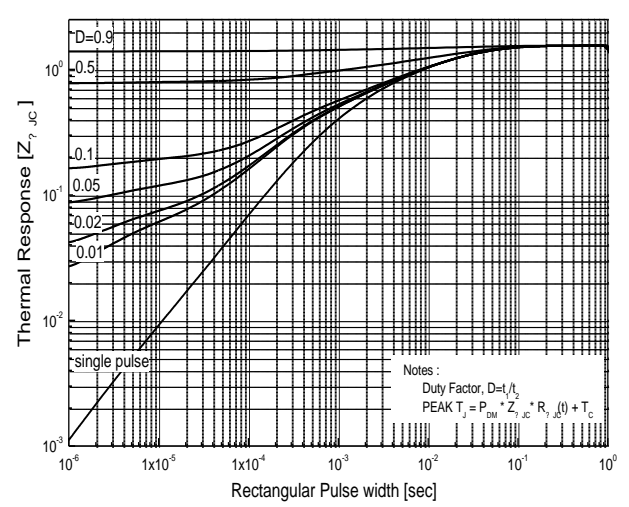
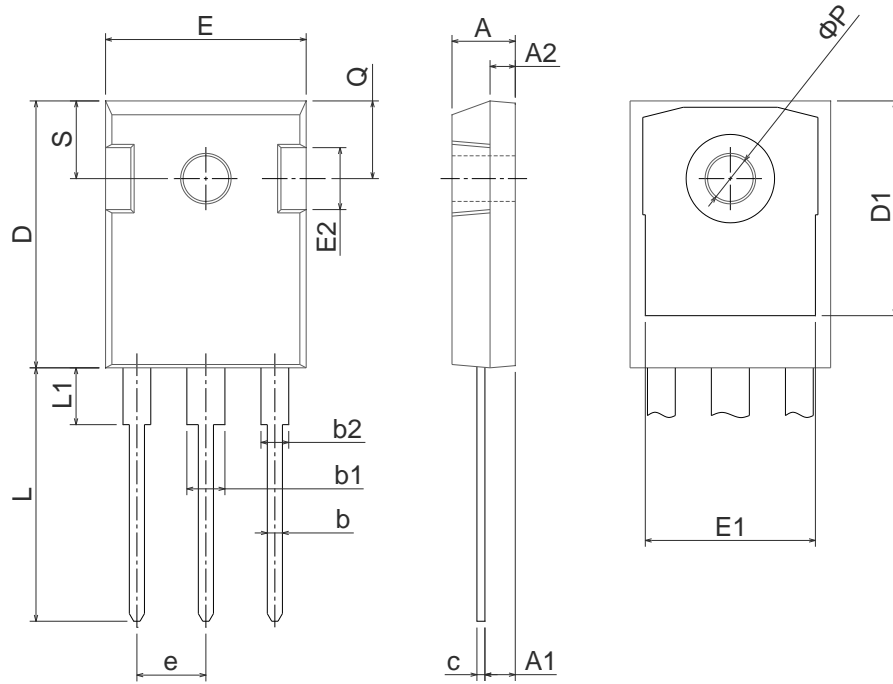


Fig.30 FRD Transient Thermal Impedance

Physical Dimension

TO-247

Dimensions are in millimeters, unless otherwise specified



Dimension	Min(mm)	Max(mm)
A	4.70	5.31
A1	2.20	2.60
A2	1.50	2.49
b	0.99	1.40
b1	2.59	3.43
b2	1.65	2.39
c	0.38	0.89
D	20.30	21.46
D1	13.08	-
E	15.45	16.26
E1	13.06	14.02
E2	4.32	5.49
e	5.45BSC	
L	19.81	20.57
L1	-	4.50
ΦP	3.50	3.70
Q	5.38	6.20
S	6.15BSC	

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